Preliminary Data Sheet No.PD 60149-G

International
IOR Rectifier

IPS022G/IPS024G

DUAL/QUAD FULLY PROTECTED POWER MOSFET SWITCH

Features

- Over temperature shutdown
- Over current shutdown
- Active clamp
- Low current & logic level input
- E.S.D protection

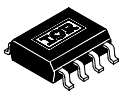
Description

The IPS022G/IPS024G are fully protected dual/quad low side SMART POWER MOSFETs respectively. They feature over-current, over-temperature, ESD protection and drain to source active clamp.These device combine a HEXFET POWER MOSFET and a gate driver. They offer full protection and high reliability required in harsh environments. The driver allows short switching times and provides efficient protection by turning OFF the power MOSFET when the temperature exceeds 165°C or when the drain current reaches 5A. These device restart once the input is cycled. The avalanche capability is significantly enhanced by the active clamp and covers most inductive load demagnetizations.

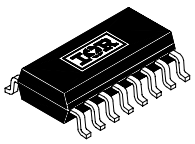
Product Summary

$R_{ds(on)}$	150mw (max)
V_{clamp}	50V
$I_{shutdown}$	5A
$T_{shutdown}$	165°C
T_{on}/T_{off}	1.5ms

Available Package

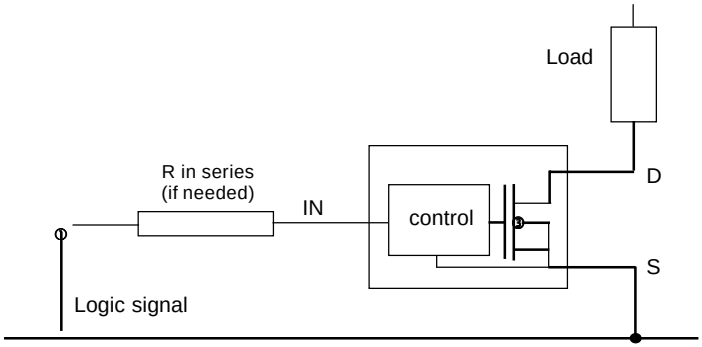


8 Lead SOIC
IPS022G
(Dual)



16 Lead SOIC
IPS024G
(Quad)

Typical Connection



Absolute Maximum Ratings

Absolute maximum ratings indicates sustained limits beyond which damage to the device may occur. All voltage parameters are referenced to SOURCE lead. ($T_{Ambient}$ = 25°C unless otherwise specified). PCB mounting uses the standard footprint with 70 mm copper thickness.

Symbol	Parameter	Min.	Max.	Units	Test Conditions
V_{ds}	Maximum drain to source voltage	—	47	V	
V_{in}	Maximum input voltage	-0.3	7		
$I_{in,\ max}$	Maximum IN current	-10	+10	mA	
$I_{sd\ cont.}$	Diode max. continuous current (1)			A	
	(å Isd mosfets, rth=125°C/W)	—	1.4		
$I_{sd\ pulsed}$	Diode max. pulsed current (1) (for ea. mosfet)	—	10		
P_d	Maximum power dissipation(1)			W	
	(å Pd mosfets, rth=125°C/W)	—	1		
ESD1	Electrostatic discharge voltage (Human Body)	—	tbd	V	C=100pF, R=1500W,
ESD2	Electrostatic discharge voltage (Machine Model)	—	tbd		C=200pF, R=0W,
T_j max.	Max. storage & operating junction temp.	-40	+150	°C	

Thermal Characteristics

Symbol	Parameter	Min.	Typ.	Max.	Units	Test Conditions
R_{th1} (2 mos on)	Thermal resistance with standard footprint (2 mosfets on)	—	100	125	°C/W	SOIC-8
R_{th2} (1 mos on)	Thermal resistance with standard footprint (1 mosfet on)	—	127	—		
R_{th3} (2 mos on)	Thermal resistance with 1" square footprint (2 mosfets on)	—	—	80		
R_{th1} (4 mos on)	Thermal resistance with standard footprint (4 mosfets on)	—	75	—		SOIC-16
R_{th2} (1mos on)	Thermal resistance with standard footprint (1 mosfet on)	—	120	—		
R_{th3} (4 mos on)	Thermal resistance with 1" square footprint (4 mosfets on)	—	60	—		

(1) Limited by junction temperature (pulsed current limited also by internal wiring)

Recommended Operating Conditions

These values are given for a quick design. For operation outside these conditions, please consult the application notes.

Symbol	Parameter	Min.	Max.	Units
$V_{ds\ (max)}$	Continuous drain to source voltage	—	35	V
V_{IH}	High level input voltage	4	6	
V_{IL}	Low level input voltage	0	0.5	
I_{ds} $T_{Amb=85^oC}$	Continuous drain current (TAmbient = 85°C, IN = 5V, rth = 100°C/W, Tj = 85°C) IPS022G	—	1	A
	(TAmbient = 85°C, IN = 5V, rth = 100°C/W, Tj = 125°C) IPS024G	—	0.7	
R_{in}	Recommended resistor in series with IN pin	0.5	5	kW
$T_{r\text{-}in\ (max)}$	Max recommended rise time for IN signal (see fig. 2)	—	1	mS
$F_{r\text{-}Isc}$ (2)	Max. frequency in short circuit condition (Vcc = 14V)	0	1	kHz

Static Electrical Characteristics

(T_j = 25°C unless otherwise specified.)

Symbol	Parameter	Min.	Typ.	Max.	Units	Test Conditions
$R_{ds(on)}$ @Tj=25°C	ON state resistance T_j = 25°C	—	120	150	mW	V_{in} = 5V, I_{ds} = 1A
$R_{ds(on)}$ @Tj=150°C	ON state resistance T_j = 150°C	—	190	260		
I_{dss} @Tj=25°C	Drain to source leakage current	0	0.5	25	mA	V_{cc} = 14V, T_j = 25°C, V_{in} = 0V
V clamp 1	Drain to source clamp voltage 1	47	52	—	V	I_d = 20mA (see Fig.3 & 4)
V clamp 2	Drain to source clamp voltage 2	—	54	60		I_d=$I_{shutdown}$ (see Fig.3 & 4)
V_{sd}	Body diode forward voltage	—	0.85	1		I_d = 2A, V_{in} = 0V
$V_{in\ clamp}$	IN to source clamp voltage	7	8.1	9.5		I_{in} = 1 mA
V_{th}	IN threshold voltage	1	1.6	2		I_d = 50mA
$I_{in,\ on}$	Input supply current (normal operation)	25	80	200	mA	V_{in} = 5V
$I_{in,\ off}$	Input supply current (protection mode)	50	130	250		V_{in} = 5V over-current triggered

Switching Electrical Characteristics

V_{cc} = 14V, Resistive Load = 10W, Rinput = 50W, 100msec pulse, T_j = 25°C, (unless otherwise specified).

Symbol	Parameter	Min.	Typ.	Max.	Units	Test Conditions
T_{on}	Turn-on delay time	—	0.5	—	msec	See figure 2
T_r	Rise time	—	1	—		
T_{rf}	Time to 130% final $R_{ds(on)}$	—	6	—		
T_{off}	Turn-off delay time	—	2	—		See figure 2
T_f	Fall time	—	1.3	—		
Q_{in}	Total gate charge	—	3.3	—	nC	V_{in} = 5V

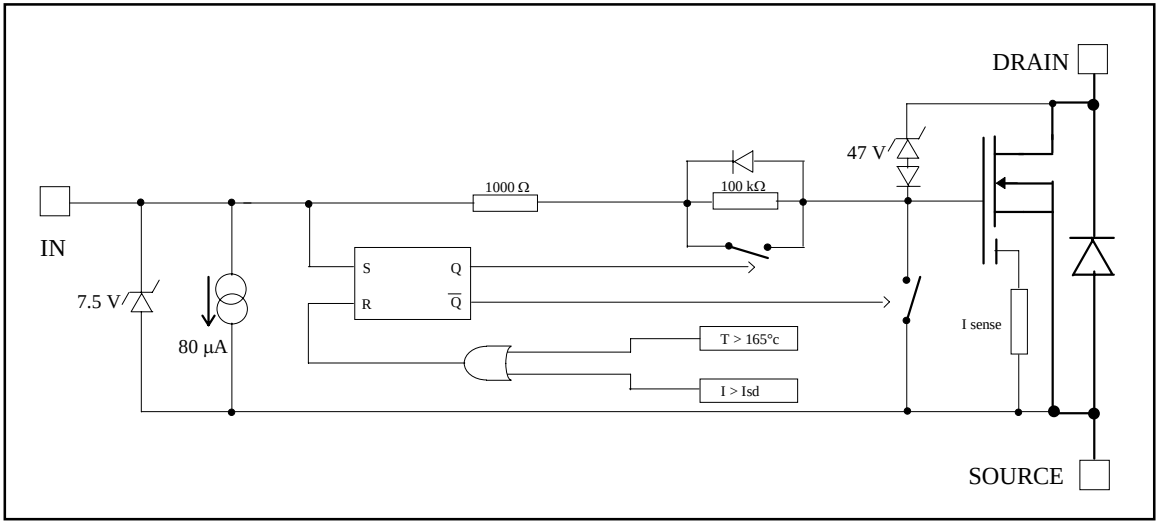
(2) Operations at higher switching frequencies is possible. See Appl. notes.

Protection Characteristics

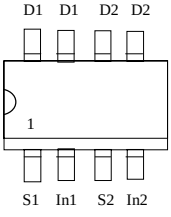
Symbol	Parameter	Min.	Typ.	Max.	Units	Test Conditions
T_{sd}	Over temperature threshold	—	165	—	°C	See fig. 1
I_{sd}	Over current threshold	—	5	—	A	See fig. 1
$V_{in,min,prot}$	Minimum IN voltage for protection	—	3	—	V	
T_{reset}	Minimum time for protection reset	—	10	—	ms	V_{in} = 0V
EOI_OT	Short circuit energy (cf application note)	—	400	—	mJ	V_{CC} = 14V

Functional Block Diagram

All values are typical

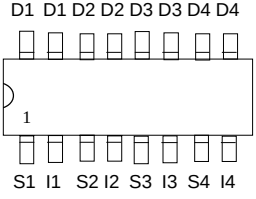


Lead Assignments



8 Lead SOIC
(Dual)

IPS022G

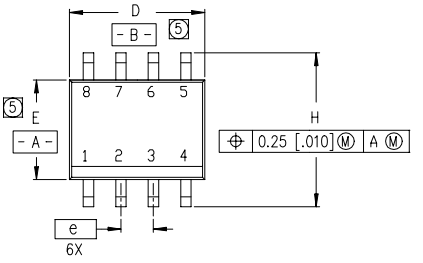


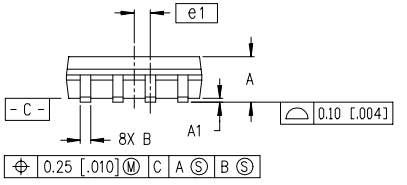
16 Lead SOIC
(Quad)

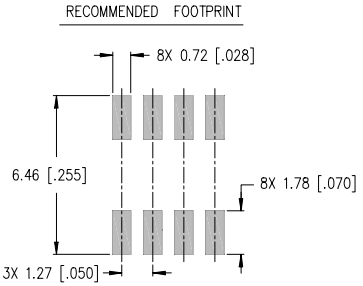
IPS024G

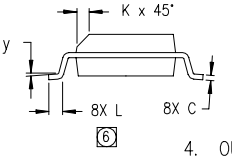
Part Number

Case Outline - 8 Lead SOIC









DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.0532	.0688	1.35	1.75
A1	.0040	.0098	0.10	0.25
B	.014	.018	0.36	0.46
C	.0075	.0098	0.19	0.25
D	.189	.196	4.80	4.98
E	.150	.157	3.81	3.99
e	.050 BASIC		1.27 BASIC	
e1	.025 BASIC		0.635 BASIC	
H	.2284	.2440	5.80	6.20
K	.011	.019	0.28	0.48
L	.016	.050	0.41	1.27
y	0°	8°	0°	8°

NOTES:

1. DIMENSIONING & TOLERANCING PER ANSI Y14.5M–1982.
2. CONTROLLING DIMENSION: MILLIMETER.
3. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
4. OUTLINE CONFORMS TO JEDEC OUTLINE MS–012AA.
5. DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS. MOLD PROTRUSIONS NOT TO EXCEED 0.25 [.006].
6. DIMENSION IS THE LENGTH OF LEAD FOR SOLDERING TO A SUBSTRATE.

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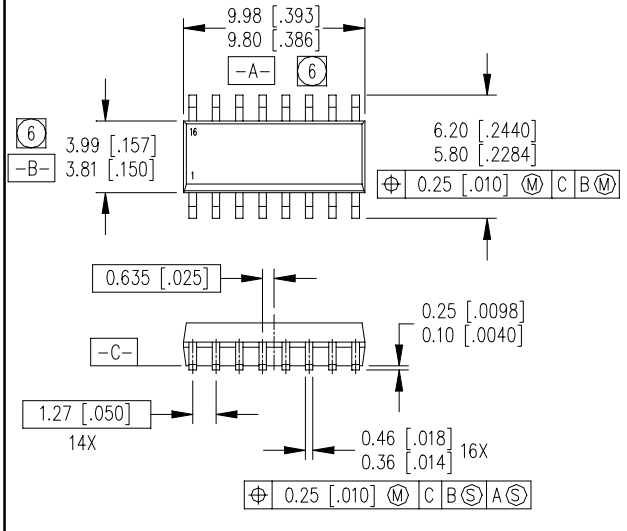
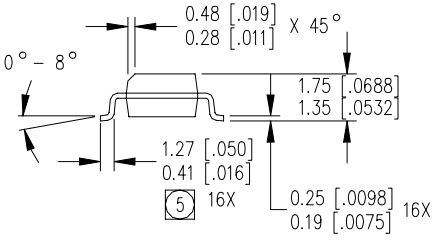
Case Outline - 16 Lead SOIC (narrow body)



NOTES:

1 DIMENSIONING & TOLERANCING PER ANSI Y14.5M–1982.
2 CONTROLLING DIMENSION: MILLIMETER
3 DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
4 OUTLINE CONFORMS TO JEDEC OUTLINE MS–012AC.
5 DIMENSION IS THE LENGTH OF LEAD FOR SOLDERING TO A SUBSTRATE.
6 DIMENSION DOES NOT INCLUDE MOLD PROTUSIONS. MOLD PROTUSIONS SHALL NOT EXCEED 0.15 [.006].



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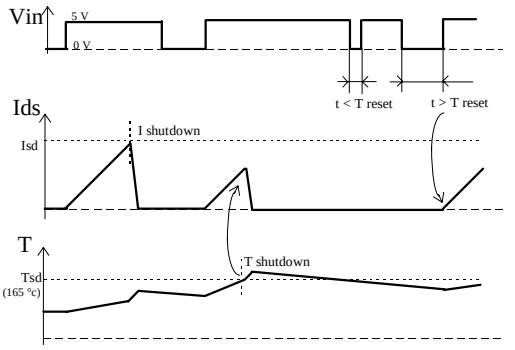

Figure 1 - Timing diagram

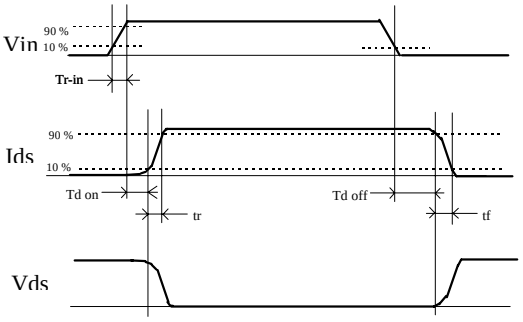

Figure 2 - IN rise time & switching time definitions

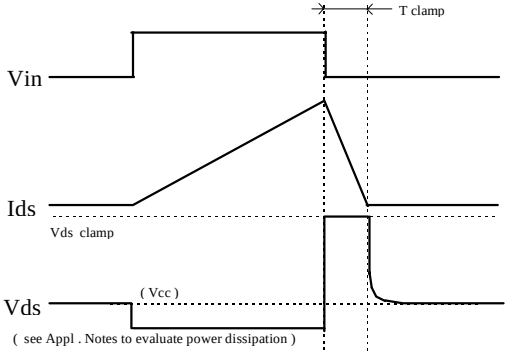

Figure 3 - Active clamp waveforms

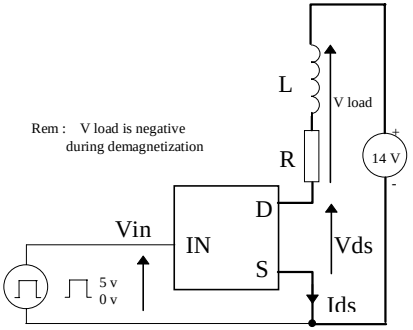

Figure 4 - Active clamp test circuit

All curves are typical values with standard footprints. Operating in the shaded area is not recommended.

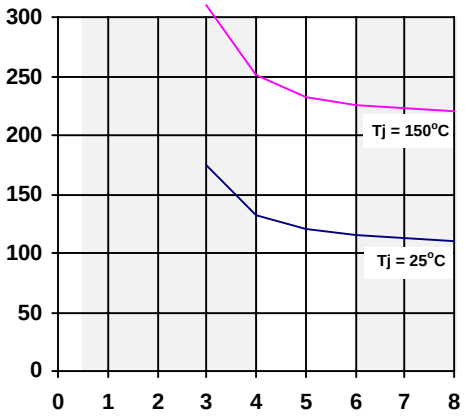

Figure 5 - Rds ON (mW) Vs Input Voltage (V)

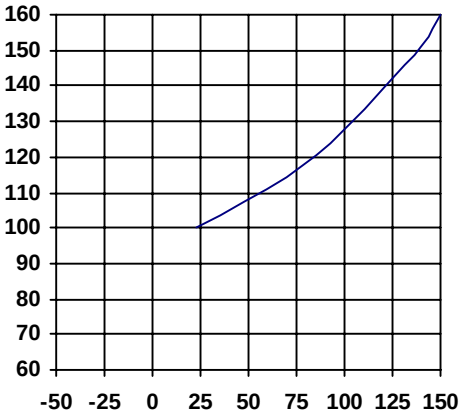

Figure 6 - Normalised Rds ON (%) Vs Tj (ºC)

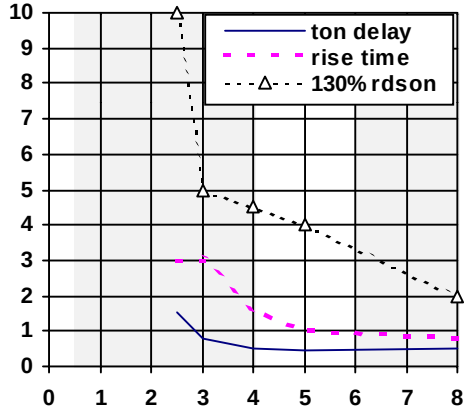

Figure 7 - Turn-ON Delay Time, Rise Time & Time to 130% final Rds(on) Vs Input Voltage (V)

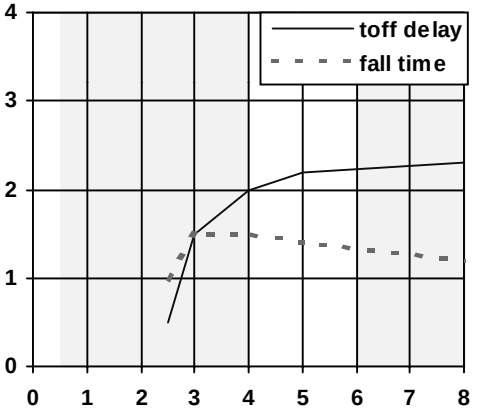

Figure 8 - Turn-OFF Delay Time & Fall Time (us) Vs Input Voltage (V)

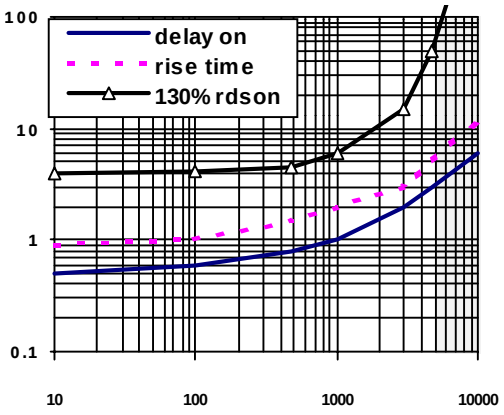

Figure 9 - Turn-ON Delay Time, Rise Time & Time to 130% final Rds(on) Vs IN Resistor (W)

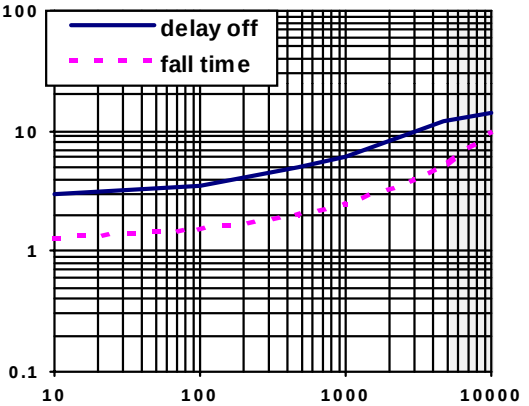

Figure 10 - Turn-OFF Delay Time & Fall Time (us) Vs IN Resistor (W)

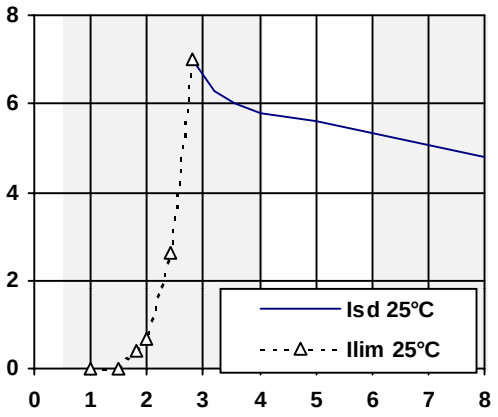

Figure 11 - Current Iim. & Ishutdown (A) Vs Vin (V)

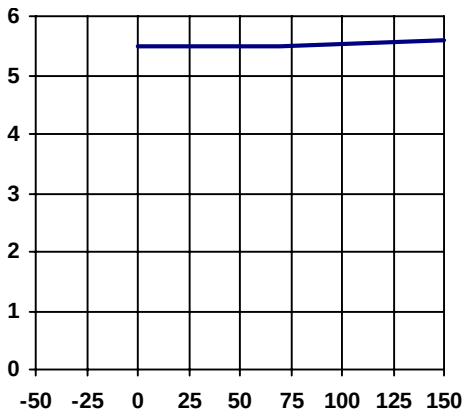

Figure 12 - Over-current (A) Vs Temperature (°C)

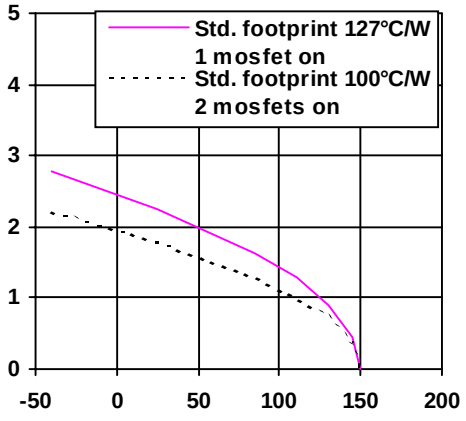

Figure 13a - Max.Cont. Ids (A)
Vs Amb. Temperature (°C) - IPS022G

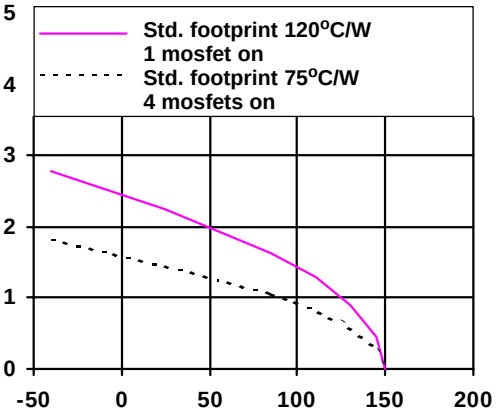

Figure 13b - Max.Cont. Ids (A)
Vs Amb. Temperature (°C) - IPS024G

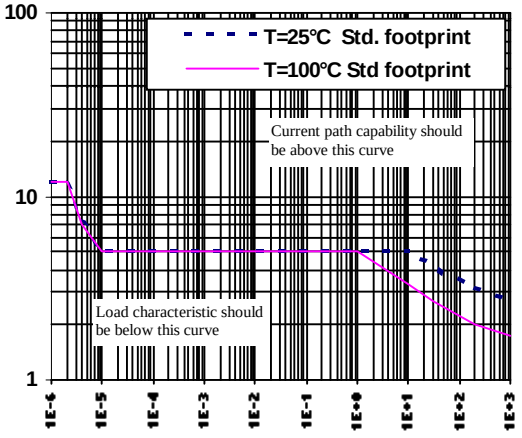

Figure 14 - Ids (A) Vs Protection Resp. Time (s)
IPS022G/IPS024G

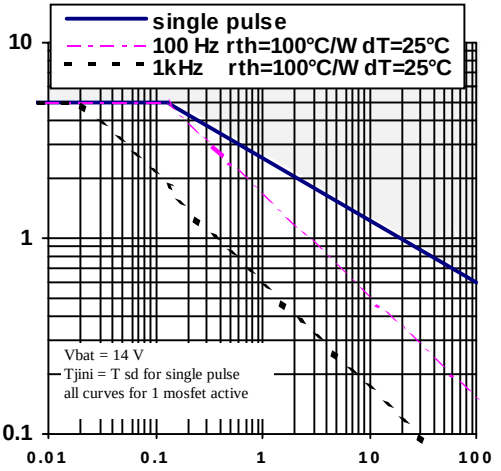

Figure 15a - Iclamp (A) Vs Inductive Load (mH)
IPS022G

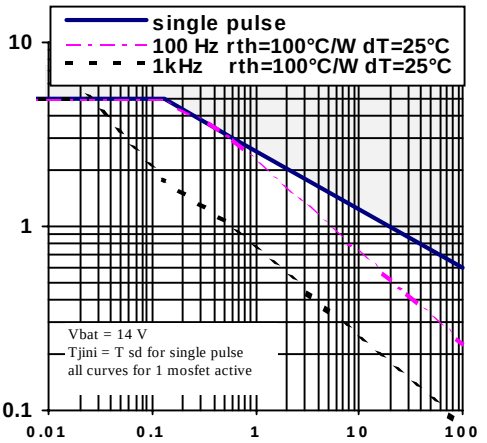

Figure 15b - Max. Iclamp (A) Vs Inductive Load (mH) - IPS024G

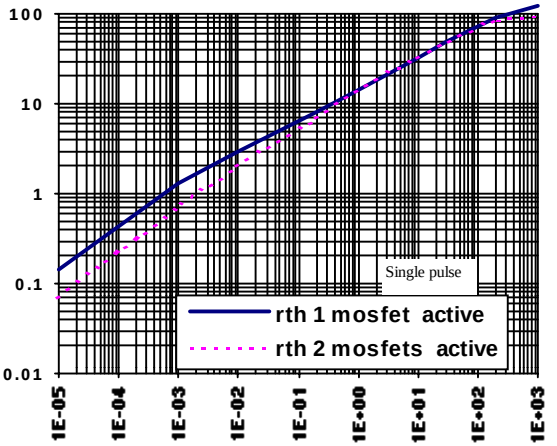

Figure 16a - Transient Thermal Imped. (ºC/W) Vs Time (s) - IPS022G

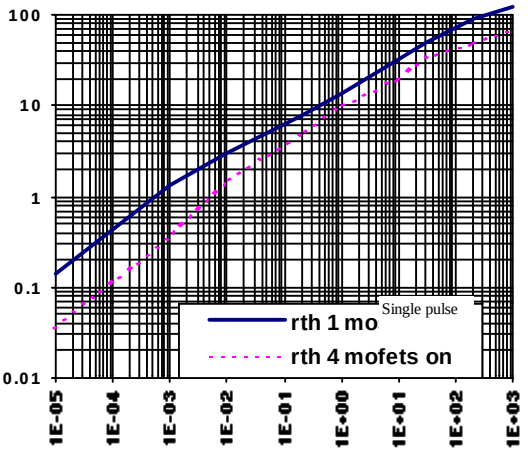

Figure 16b - Transient Thermal Imped. (ºC/W) Vs Time (s) - IPS024G

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